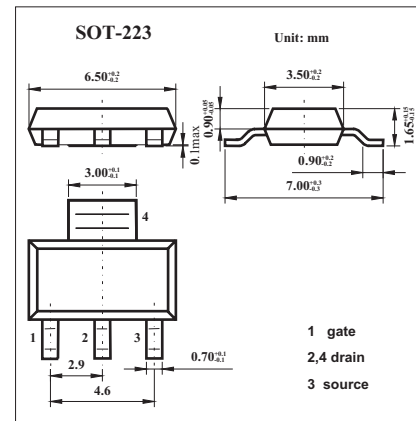
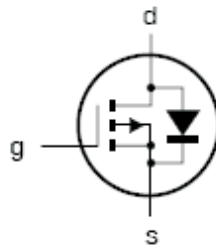


P-Channel Enhancement Mode Vertical D-MOS Transistor

KSP230

■ Features

- Direct interface to C-MOS, TTL, etc
- High-speed switching
- No secondary breakdown



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

| Parameter | Symbol | Rating | Unit |
|---|---------------|-------------|------------------|
| Drain-source voltage (DC) | V_{DS} | -300 | V |
| Gate-source voltage (DC) open drain | V_{GSO} | ± 20 | V |
| Drain current (DC) | I_D | -210 | mA |
| Peak drain current | I_{DM} | -0.75 | A |
| Total power dissipation * | P_{tot} | 1.5 | W |
| Storage temperature | T_{stg} | -65 to +150 | $^\circ\text{C}$ |
| Operating junction temperature | T_j | 150 | $^\circ\text{C}$ |
| thermal resistance from junction to ambient * | $R_{th\ j-a}$ | 83.3 | K/W |

*Device mounted on an epoxy printed-circuit board, 40 X 40 X 1.5 mm;
mounting pad for drain lead minimum 6 cm².

KSP230

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

| Parameter | Symbol | Testconditons | Min | Typ | Max | Unit |
|------------------------------------|---------------|--|------|-----|-----------|---------------|
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $I_D = -10\ \mu\text{A}$, $V_{GS} = 0\text{V}$ | -300 | | | V |
| Gate-source threshold voltage | V_{GSth} | $V_{DS} = V_{GS}$, $I_D = -1\ \text{mA}$ | -1.7 | | -2.55 | V |
| Drain-source leakage current | I_{DSS} | $V_{DS} = -240\ \text{V}$, $V_{GS} = 0\text{V}$ | | | -100 | μA |
| Gate leakage current | I_{GSS} | $V_{GS} = \pm 20\text{V}$, $V_{DS} = 0$ | | | ± 100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $I_D = -170\ \text{mA}$, $V_{GS} = -10\ \text{V}$ | | | 17 | Ω |
| Forward transfer admittance | $ y_{fs} $ | $V_{DS} = -25\ \text{V}$, $I_D = -170\ \text{mA}$ | 100 | | | mS |
| Input capacitance | C_{iss} | $V_{DS} = -25\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$ | | 60 | 90 | pF |
| Output capacitance | C_{oss} | | | 15 | 30 | |
| Reverse transfer capacitance | C_{rss} | | | 5 | 15 | |
| Turn-on time (See Fig.1and Fig.2) | t_{on} | $V_{GS} = 0\ \text{V}$ to $-10\ \text{V}$, $I_D = -250\ \text{mA}$, $V_{DD} = -50\ \text{V}$, | | 5 | 10 | ns |
| Turn-off time (See Fig.1and Fig.2) | t_{off} | $V_{GS} = -10\ \text{V}$ to $0\ \text{V}$, $I_D = -250\ \text{mA}$, $V_{DD} = -50\ \text{V}$, | | 15 | 30 | |

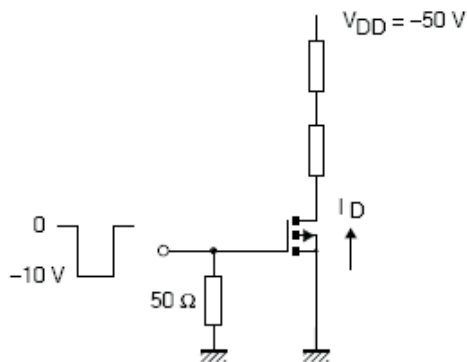


Fig.1 Switching time test circuit.

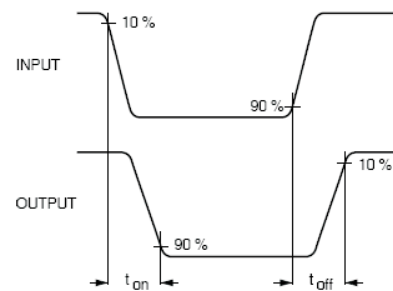


Fig.2 Input and output waveforms.